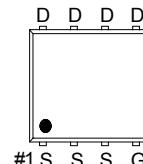
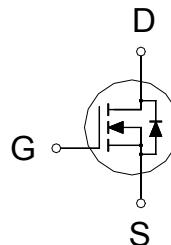


**NIKO-SEM**
**N-Channel Enhancement Mode  
Field Effect Transistor**
**PE606BA  
PDFN 3x3P  
Halogen-Free & Lead-Free**
**PRODUCT SUMMARY**

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D^3$
30V	18mΩ	23A


G : GATE  
D : DRAIN  
S : SOURCE
**ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$  Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>3</sup>	$I_D$	23	A
		15	
$T_C = 25^\circ\text{C}$		10.6	
$T_C = 100^\circ\text{C}$		8.5	
Continuous Drain Current <sup>3</sup>			
$T_A = 25^\circ\text{C}$			
$T_A = 70^\circ\text{C}$			
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	60	
Avalanche Current	$I_{AS}$	12.6	
Avalanche Energy	$E_{AS}$	7.9	mJ
Power Dissipation	$P_D$	17	
		7	
$T_C = 25^\circ\text{C}$		3.5	
$T_C = 100^\circ\text{C}$		2.2	
Power Dissipation <sup>4</sup>			
$T_A = 25^\circ\text{C}$			
$T_A = 70^\circ\text{C}$			
Operating Junction & Storage Temperature Range	$T_j, T_{stg}$	-55 to 150	°C

**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient <sup>2</sup>	$R_{\theta JA}$		35	°C / W
Junction-to-Ambient <sup>2</sup>	$R_{\theta JA}$		70	
Junction-to-Case	$R_{\theta JC}$		7	

<sup>1</sup>Pulse width limited by maximum junction temperature.<sup>2</sup>The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ .<sup>3</sup>Package limitation current is 11A<sup>4</sup>The Power dissipation is based on  $R_{\theta JA}$  t ≤ 10s value.

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ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	1.3	1.75	2.3	
Gate-Body Leakage	$I_{\text{GSS}}$	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 24\text{V}, V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 55^\circ\text{C}$			1 10	$\mu\text{A}$
Drain-Source On-State Resistance <sup>1</sup>	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 4.5\text{V}, I_D = 6\text{A}$		19	27	$\text{m}\Omega$
		$V_{\text{GS}} = 10\text{V}, I_D = 7\text{A}$		13	18	
Forward Transconductance <sup>1</sup>	$g_{\text{fs}}$	$V_{\text{DS}} = 10\text{V}, I_D = 7\text{A}$		25		S
<b>DYNAMIC</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 15\text{V}, f = 1\text{MHz}$		333		pF
Output Capacitance	$C_{\text{oss}}$			64		
Reverse Transfer Capacitance	$C_{\text{rss}}$			43		
Gate Resistance	$R_g$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		2		$\Omega$
Total Gate Charge <sup>2</sup>	$Q_{\text{g}(\text{VGS}=10\text{V})}$	$V_{\text{DS}} = 15\text{V}, I_D = 7\text{A}$		7.5		nC
	$Q_{\text{g}(\text{VGS}=4.5\text{V})}$			4.3		
Gate-Source Charge <sup>2</sup>	$Q_{\text{gs}}$			1.1		
Gate-Drain Charge <sup>2</sup>	$Q_{\text{gd}}$			2.3		
Turn-On Delay Time <sup>2</sup>	$t_{\text{d}(\text{on})}$			17		
Rise Time <sup>2</sup>	$t_r$	$V_{\text{DD}} = 15\text{V}$ $I_D \geq 7\text{A}, V_{\text{GEN}} = 10\text{V}, R_G = 6\Omega$		17		nS
Turn-Off Delay Time <sup>2</sup>	$t_{\text{d}(\text{off})}$			37		
Fall Time <sup>2</sup>	$t_f$			18		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (<math>T_J = 25^\circ\text{C}</math>)</b>						
Continuous Current <sup>3</sup>	$I_S$				15	A
Forward Voltage <sup>1</sup>	$V_{\text{SD}}$	$I_F = 7\text{A}, V_{\text{GS}} = 0\text{V}$			1.1	V
Reverse Recovery Time	$t_{\text{rr}}$	$I_F = 7\text{A}, \frac{dI_F}{dt} = 100\text{A}/\mu\text{s}$			8.4	nS
Reverse Recovery Charge	$Q_{\text{rr}}$				2.2	nC

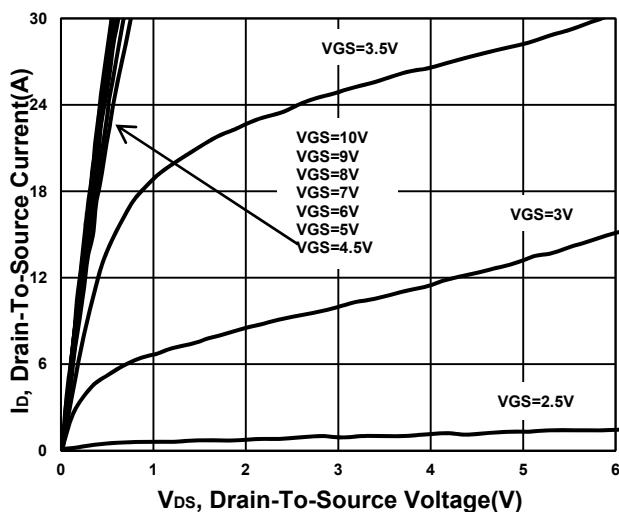
<sup>1</sup>Pulse test : Pulse Width  $\leq 300\ \mu\text{sec}$ , Duty Cycle  $\leq 2\%$ .<sup>2</sup>Independent of operating temperature.<sup>3</sup>Package limitation current is 11A

**NIKO-SEM**

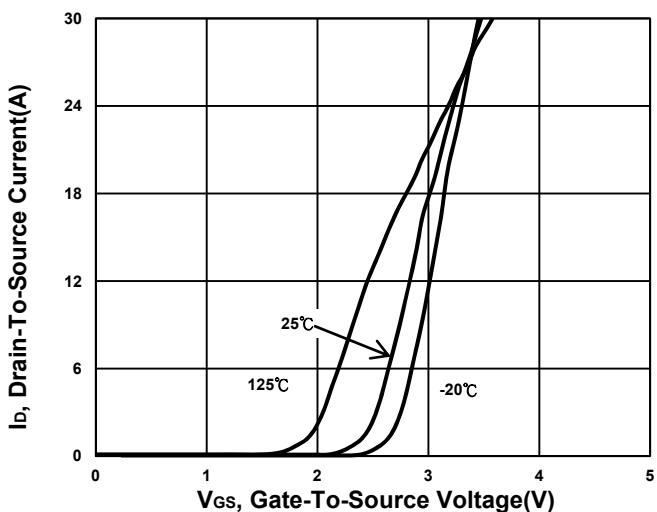
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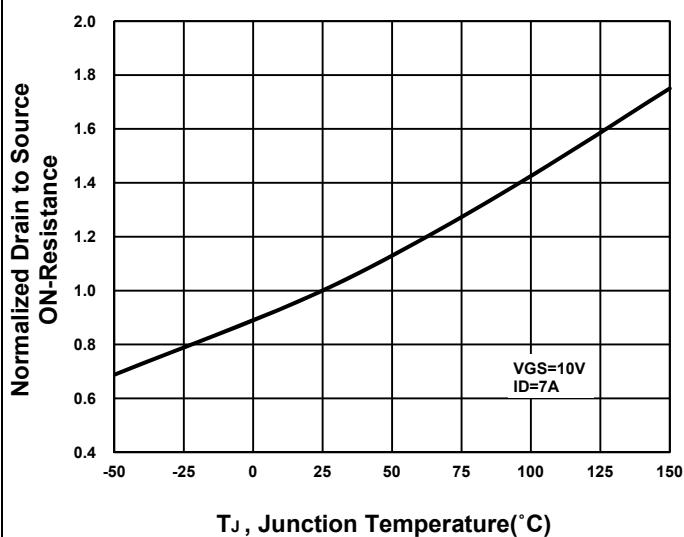
**Output Characteristics**



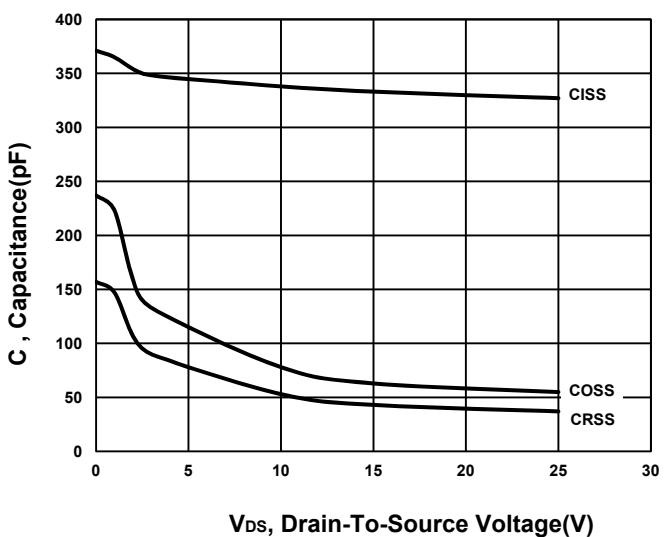
**Transfer Characteristics**



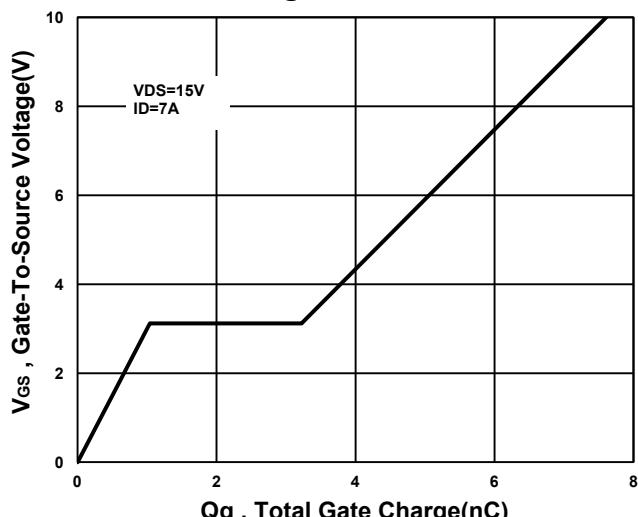
**On-Resistance VS Temperature**



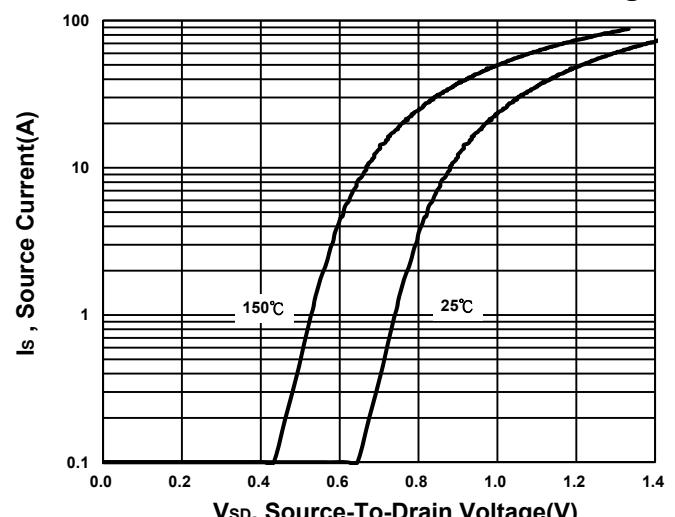
**Capacitance Characteristic**



**Gate charge Characteristics**



**Source-Drain Diode Forward Voltage**



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